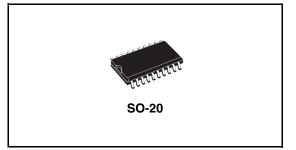


# L6585D

# Combo IC for PFC and ballast control

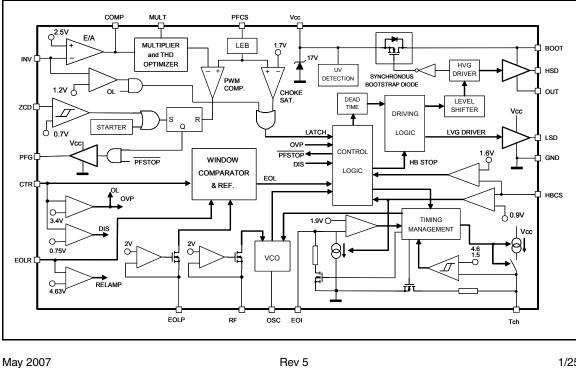
## **Features**

- Pre-heating and ignition phases independently programmable
- Ignition voltage control
- Transition mode PFC with over-current protection
- Programmable and precise End-of-life protection compliant with all ballast configurations
- Auto-adjusting half-bridge over-current control
- Automatic re-lamp
- 3% oscillator precision
- 1.2µs dead time
- PFC over-voltage protection and feedback disconnection
- Under voltage lock-out



## **Applications**

Electronic ballast



#### Figure 1. **Block diagram**

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## 1 Device description

Designed in High-voltage BCD Off-line technology, the L6585D embeds a PFC controller, a half-bridge controller, the relevant drivers and the logic necessary to build an electronic ballast.

The advanced and precise logic circuitry, combined with the programmability of the End-of-Life windows comparator threshold, makes the L6585D compliant with either "lamp-toground" or "block capacitor-to ground" configurations.

Another outstanding feature is the possibility of controlling and limiting the lamp voltage during the ignition phase.

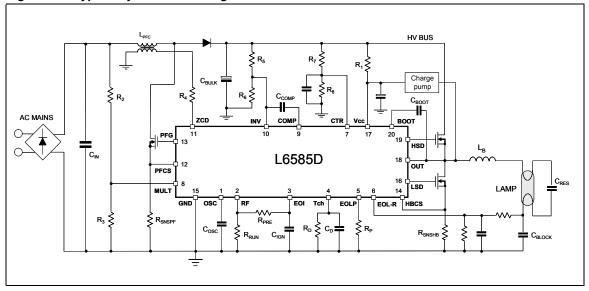
The pre-heating and ignition durations are independently settable as well as the half-bridge switching frequencies for each operating phases (pre-heating, ignition and normal mode).

Other features (half-bridge over-current with frequency increase, PFC over-voltage) allow building a reliable and flexible solution with a reduced part count.

The PFC section achieves current mode control operating in Transition Mode; the highly linear multiplier includes a special circuit, able to reduce AC input current distortion, that allows wide-range-mains operation with an extremely low THD, even over a large load range.

The PFC output voltage is controlled by means of a voltage-mode error amplifier and a precise internal voltage reference.

The driver of the PFC is able to provide 300mA (source) and 600mA (sink) and the drivers of the half-bridge provide 290mA source and 480mA sink.

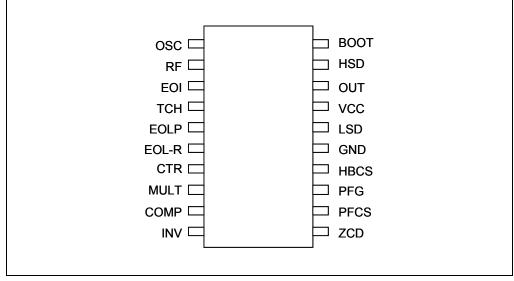


#### Figure 2. Typical system block diagram

# 2 Pin settings

## 2.1 Connection







# 2.2 Functions

### Table 1. Pin functions

Pin num.	Name	Function
1	OSC	An external capacitor to GND fixes the half-bridge switching frequency with a $\pm 3\%$ precision.
2	RF	Voltage reference able to source up to 240 $\mu$ A; the current sunk from this pin fixes the switching frequency of the half-bridge for each operating state. A resistor (R <sub>RUN</sub> ) connected to ground sets the half-bridge operating frequency combined with the capacitor connected to the pin OSC. A resistor connected to EOI (R <sub>PRE</sub> ) – in parallel with R <sub>RUN</sub> – sets the maximum half-bridge switching frequency during pre-heating.
3	EOI	Connected to ground by a capacitor that, combined with R <sub>PRE</sub> , determines the ignition duration Pre-heating: low impedance to set high switching frequency Ignition and run mode: high impedance with controlled current sink in case of HBCS threshold triggering.
4	Tch	Pin for setting the pre-heating time and the protection intervention. Connect a RC parallel network ( $R_D$ and $C_D$ ) to ground <b>Pre-heating:</b> the $C_D$ is charged by an internal current generator. When the pin voltage reaches 4.63V the generator is disabled and the capacitor discharges because of $R_D$ ; once the voltage drops below 1.52V, the preheating finishes, the ignition phase starts and the $R_DC_D$ is discharged to ground. <b>Run mode:</b> according to the kind of fault (either over-current or EOL) the internal generator charges the RC parallel network and appropriate actions are taken to stop the application. During proper behavior of the IC, this pin is low impedance.
5	EOLP	Pin to program the EOL comparator. It is possible to select both the EOL sensing method and the window comparator amplitude by connecting a resistor ( $R_{EOLP}$ ) to ground.
6	EOL-R	<ul> <li>Input for the window comparator and re-lamp function.</li> <li>It can be used to detect the lamp ageing for either "lamp to ground" and "block capacitor to ground" configurations.</li> <li>According to the EOLP pin setting, it is possible to program: <ul> <li>the window amplitude (V<sub>W</sub>)</li> <li>the center of the window (V<sub>SET</sub>) either fixed or in tracking with the PFC output bus.</li> </ul> </li> <li>This function is blanked during the ignition phase.</li> <li>In case of either lamp disconnection or removal, a second threshold (V<sub>SL-UP</sub>) crossing latches the IC and drives the chip in "ready-mode" so that when the voltage at EOL-R pin is brought below V<sub>SL-DOWN</sub> (re-lamp) a new preheating/ignition sequence is repeated.</li> </ul>
7	CTR	<ul> <li>Input pin for:</li> <li>PFC over-voltage detection: the PFC driver is stopped until the voltage returns in the proper operating range</li> <li>Feedback disconnection detection</li> <li>reference for End-of-life in case tracking reference;</li> <li>shut-down: forcing the pin to a voltage lower than 0.75V, the IC shuts down in unlatched condition.</li> </ul>
8	MULT	Main input to the multiplier. This pin is connected to the rectified mains voltage via a resistor divider and provides the sinusoidal reference to the PFC current loop.



Table 1.	1. Pin functions (continued)				
Pin num.	Name	Function			
9	COMP	Output of the error amplifier. A compensation network is placed between this pin and INV to achieve stability of the PFC voltage control loop and ensure high power factor and low THD.			
10	INV	Inverting input of the error amplifier. The information on the output voltage of the PFC pre-regulator is fed into the pin through a resistor divider. Input for the feedback disconnection comparator			
11	ZCD	Boost inductor's demagnetization sensing input for PFC transition-mode operation. A negative-going edge triggers PFC MOSFET turn-on. During start-up or when the voltage is not high enough to arm the internal comparator (e.g. AC Mains peak), the PFC driver is triggered by means of an internal starter.			
12	PFCS	Input to the PFC PWM comparator. The current flowing in the PFC mosfet is sensed by a resistor; the resulting voltage is applied to this pin and compared with an internal sinusoidal-shaped reference, generated by the multiplier, to determine the PFC MOSFET's turn-off. A second comparison level detects abnormal currents (e.g. due to boost inductor saturation) and, on this occurrence, shuts down and latches the IC reducing its consumption to the start-up. An internal LEB prevents undesired function triggering.			
13	PFG	PFC gate driver output. The totem pole output stage is able to drive power MOSFET'S with a peak current of 300mA source and 600mA sink.			
14	HBCS	<ul> <li>2-levels half-bridge current monitor for current control.</li> <li>The current flowing in the HB mosfet is sensed by a resistor; the resulting voltage is applied to this pin.</li> <li>Low threshold (active during run mode): in case of thresholds crossing, the IC reacts with self-adjusting frequency increase in order to limit the half-bridge (lamp) current.</li> <li>High threshold: <ul> <li>ignition: in case of thresholds crossing during the frequency shift, the IC reacts with self-adjusting frequency increase in order to limit the lamp voltage and preventing operation below resonance.</li> <li>run mode: in case of thresholds crossing because of current spikes (due e. g. to capacitive mode / cross-conduction), the L6585D latches to avoid MOSFETs damaging,</li> </ul> </li> </ul>			
15	GND	Ground. Current return for both the signal part of the IC and the gate driver.			
16	LSD	Low side driver output: the output stage can deliver 290mA source and 480mA sink (typ. values).			
17	VCC	Supply Voltage of both the signal part of the IC and the gate driver. Clamped with a Zener inside.			
18	OUT	High Side Driver Floating Reference. This pin must be connected close to the source of the high side power MOS.			
19	HSD	High side driver output: the output stage can deliver 290mA source and 480mA (typ. values).			
20	BOOT	Bootstrapped Supply Voltage. Between this pin and V <sub>CC</sub> , the bootstrap capacitor must be connected. A patented integrated circuitry replaces the external bootstrap diode, by means of a high voltage DMOS, synchronously driven with the low side power MOSFET			

Table 1. Pin functions (continued)

# 3 Electrical data

# 3.1 Maximum ratings

Symbol	Pin	Parameter	Value	Unit	
V <sub>BOOT</sub>	20	Floating supply voltage	-1 to 618	V	
V <sub>OUT</sub>	18	Floating ground voltage	-3 to V <sub>BOOT -</sub> 18	V	
dV <sub>OUT</sub> /dt	18	Floating ground max. slew rate	50	V/ns	
V <sub>CC</sub>	17	IC Supply voltage (I <sub>CC</sub> = 20mA) <sup>(1)</sup>	Self-limited	V	
	1, 3, 4, 8, 10, 12	Analog input and outputs	-0.3 to 5	V	
	2, 5		-0.3 to 2.7	V	
	6		Vcc		
	7		-0.3 to 7	V	
	14		-5 to 5		
	9, 11	ZCD clamp (I <sub>ZCD</sub> < 4mA)	Self-limited		
I <sub>RF</sub>	2	Current capability	240	μA	
I <sub>EOLP</sub>	5	Current capability	100	μA	
F <sub>OSC(MAX)</sub>	DSC(MAX) Maximum operating frequency		250	KHz	
P <sub>TOT</sub>		Power dissipation @T <sub>A</sub> = 70°C	0.83	W	

### Table 2. Absolute maximum ratings

1. The device has an internal Clamping Zener between GND and the VCC pin, it must not be supplied by a Low Impedance Voltage Source.

Note: ESD immunity for pins 18, 19 and 20 is guaranteed up to 900V (Human Body Model)

## **3.2** Thermal data

### Table 3. Thermal data

Symbol	Description	Value	Unit
R <sub>thJA</sub>	Max. thermal resistance junction to ambient	120	°C/W
TJ	Junction operating temperature range	-40 to 150	°C
T <sub>STG</sub>	Storage temperature	-55 to 150	°C



# 4 Electrical characteristics

 $V_{CC}$  = 15V,  $T_A$  = 25°C,  $C_L$  = 1nF,  $C_{OSC}$  = 470pF,  $R_{RUN}$  = 47K, unless otherwise specified

Table 4. Electrical characteristics

Symbol	Pin	Parameter	Test condition	Min	Тур	Мах	Unit
Supply volta	ge	1	1			1	
Vcc	V <sub>CC</sub>	Operating range	After turn-on	11		16	V
V <sub>CC(on)</sub>	V <sub>CC</sub>	Turn-on threshold	(1)	13.6	14.3	15	V
V <sub>CC(OFF)</sub>	V <sub>CC</sub>	Turn-off threshold	(1)	9.6	10.3	11	V
VZ	V <sub>CC</sub>	Zener Voltage	lcc = 20mA	16.2	17.2	17.7	V
Supply curre	ent						
I <sub>ST-UP</sub>	V <sub>CC</sub>	Start-up current	Before turn-on @ 13V		250	370	μA
ICC	V <sub>CC</sub>	Operating supply current			7		mA
lq	V <sub>CC</sub>	Residual current	IC latched			370	μA
PFC section	– multiplie	r input	1			1	
IMULT	MULT	Input bias current	V <sub>MULT</sub> = 0			-1	μA
V <sub>MULT</sub>	MULT	Linear operation range	V <sub>COMP</sub> = 3V	0 to 3			V
$\Delta V_{CS}$	MULT	Output max. slope	V <sub>MULT</sub> = 0 to 1V, V <sub>COMP</sub> = Upper clamp		0.75		V/V
K <sub>M</sub>	MULT	Gain	$V_{MULT} = 1V, V_{COMP} = 3V$		0.52		1/V
PFC section		Difier				l	
VINV	INV	Voltage feedback input threshold		2.45	2.5	2.55	V
	INV	Line regulation	V <sub>CC</sub> = 10.3V to 16V			50	mV
linv	INV	Input bias current				-1	μA
Gv	INV	Voltage gain	Open loop <sup>(2)</sup>	60	80		dB
GB	INV	Gain-bandwidth product	(2)		1		MHz
ICOMP	COMP	Source current	$V_{COMP} = 4V, V_{INV} = 2.4 V$		-2.6		mA
		Sink current	$V_{COMP} = 4V, V_{INV} = 2.6 V$		4		mA
V <sub>COMP</sub>	COMP	Upper clamp voltage	I <sub>SOURCE</sub> = 0.5 mA		4.2		V
		Lower clamp voltage	I <sub>SINK</sub> = 0.5 mA		2.25		V
VDIS	INV	Open loop detection threshold	CTR > 3.4		1.2		V
	COMP	Static OVP threshold		2.1	2.25	2.4	V

Symbol	Pin	Parameter	Test condition	Min	Тур	Мах	Unit
CTR pin							
DIO	OTD	Disable threshold	Falling edge		0.75		V
DIS	CTR	Hysteresys			120		mV
PFOV	CTR	Dynamic PFC overvoltage	Rising edge		3.4		V
		Hysteresys			140		mV
		Available range as tracking reference	Lower threshold (falling)		1.7		V
	CTR		Hysteresys		0.12		
on			Higher threshold (rising)		3.4		V
			Hysteresys		0.14		
PFC section	- current s	sense comparator					
ICS	PFCS	Input bias current	$V_{CS} = 0$			-1	μA
tLEB	PFCS	Leading edge blanking	(2)	100	200	300	ns
VCSdis	PFCS	IC disable level		1.65	1.75	1.85	V
td(H-L)	PFCS	Delay to output			120		ns
V <sub>CSclamp</sub>	PFCS	Current sense reference clamp	V <sub>COMP</sub> = Upper clamp	1.0	1.08	1.16	V
PFC section	– zero cur	rent detector			•		
VZCDH	ZCD	Upper clamp voltage	I <sub>ZCD</sub> = 2.5 mA	5			V
VZCDL	ZCD	Lower clamp voltage	I <sub>ZCD</sub> = -2.5 mA	-0.3	0	0.3	V
VZCDA	ZCD	Arming voltage (positive-going edge)	(2)		1.4		V
VZCDT	ZCD	Triggering voltage (negative-going edge)	(2)		0.7		V
IZCDb	ZCD	Input bias current	V <sub>ZCD</sub> = 1 to 4.5 V			1	μA
I <sub>ZCDsrc</sub>	ZCD	Source current capability		-4			mA
I <sub>ZCDsnk</sub>	ZCD	Sink current capability		4			mA
PFC section	- gate driv	ver					
	DEO	Outrast bisk (law)	I <sub>SINK</sub> = 10mA			0.2	V
	PFG	Output high/low	I <sub>SOURCE</sub> = 10mA	14.5			V
tf	PFG	Fall time			40	90	ns
tr	PFG	Rise time			90	140	ns
I <sub>SINK</sub>	PFG	Peak sink current		475	600		mA
ISOURCE	PFG	Peak source current		200	300		mA
	PFG	Pull-down resistor			10		kΩ

Table 4. Electrical characteristics (continued)



Symbol	Pin	Parameter	Test condition	Min	Тур	Max	Unit	
Half bridge s	section – Ti	ming & oscillator						
I <sub>CH</sub>	Т <sub>СН</sub>	Charge current	V <sub>TCH</sub> = 2.2V		30		μA	
V <sub>CHP</sub>	т <sub>сн</sub>	Charge threshold (positive going-edge)	(1)		4.63		V	
V <sub>CHN</sub>	т <sub>сн</sub>	Discharge threshold (negative going edge)	(1)		1.50		V	
	т <sub>сн</sub>	Leakage current	1.5V < V <sub>TCH</sub> < 4.5V, falling			0.1	μA	
R <sub>TCH</sub>	Т <sub>СН</sub>	Internal impedance	Run mode		150	200	Ω	
	EOI	Open state current	$V_{EOI} = 2V$			0.15	μA	
R <sub>EOI</sub>	EOI	EOI impedance	During pre-heating			150	Ω	
			Tspike = 200ns <sup>(3)</sup>		20			
	501	EOI current generator	Tspike = 400ns <sup>(3)</sup>		100		1.	
I <sub>EOI</sub>	EOI	DI EOI during igniti mode	during ignition and run mode	Tspike = 600ns <sup>(3)</sup>		200		μA
			Tspike = 1µs <sup>(3)</sup>	270			1	
V <sub>EOI</sub>	EOI	EOI threshold	(1)	1.83	1.9	1.98	V	
V <sub>REF</sub>	RF	Reference voltage	(1)	1.92	2	2.08	V	
IRF	RF	Max current capability		240			μA	
	OSC	Rising threshold	(1)		3.7		V	
	OSC	Falling threshold	(1)		0.9		V	
D	OSC	Output duty cycle		48	50	52	%	
T <sub>DEAD</sub>	OSC	Dead time		0.96	1.2	1.44	μs	
f <sub>RUN</sub>	OSC	Half-bridge oscillation frequency (run mode)		58.4	60.2	62	KHz	
f <sub>PRE</sub>	OSC	Half-bridge oscillation frequency (pre heating)	R <sub>PRE</sub> =50K	113.2	116.7	120.2	KHz	
Half bridge s	section – Ei	nd Of Life FUNCTION and	d re-lamp comparator		1	1		
	EOLP	Current capability		100			μA	
	EOLP	Reference voltage		1.92	2	2.08	V	
	EOL-R	Operating range	EOLP=27K	0.95		4.15	V	
Vs	EOL-R	Window comparator	220K = R <sub>EOLP</sub> = 270K or 22K = R <sub>EOLP</sub> = 27K	tracking with CTR		v		
- 3		reference	R <sub>EOLP</sub> > 620K or 75K = R <sub>EOLP</sub> = 91K		2.5		-	
V <sub>W</sub>		Half window amplitude	220K = R <sub>EOLP</sub> = 270K or 75K = R <sub>EOLP</sub> = 91K		220		mV	
• W			R <sub>EOLP</sub> > 620K or 22K = R <sub>EOLP</sub> = 27K		720		mV	

Table 4. Electrical characteristics (continued)

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Symbol	Pin	Parameter	Test condition	Min	Тур	Мах	Unit
	EOL-R	Sink/source capability			2.5		μA
	EOL-R	Relamp comparator			4.63		V
		hysteresys			160		mV
Half bridge s	section – Ha	alf-bridge current sense	-	•			
HBCSH	HBCS	Frequency increase threshold	V <sub>EOI</sub> < 1.9V ( <i>ignition</i> )	1.53	1.6	1.66	V
HBCSL	HBCS		V <sub>EOI</sub> > 1.9V ( <i>run mode</i> )	0.85	0.91	0.97	V
	HBCS	Latched threshold	Run mode	1.53	1.6	1.66	V
Half bridge s	section – Lo	ow side gate driver	·				
	LSD	Output low voltage	I <sub>SINK</sub> = 10mA			0.3	V
	LSD	Output high voltage	I <sub>SOURCE</sub> = 10mA	14.5			V
	LSD	Peak source current		200	290		mA
	LSD	Peak sink current		400	480		mA
T <sub>RISE</sub>	LSD	Rise time			120		ns
T <sub>FALL</sub>	LSD	Fall time			80		ns
	LSD	Pull-down resistor		;	45		KΩ
Half bridge s	section – Hi	gh side gate driver (volta	iges referred to OUT)				
	HSD	Output low voltage	I <sub>SINK</sub> = 10mA			V <sub>OUT</sub> + 0.3	V
	HSD	Output high voltage	I <sub>SOURCE</sub> = 10mA	V <sub>BOOT</sub> _ 0.5			V
	HSD	Peak source current		200	290		mA
	HSD	Peak sink current		400	480		mA
T <sub>RISE</sub>	HSD	Rise time			120		ns
T <sub>FALL</sub>	HSD	Fall time			80		ns
	HSD	HSD-OUT pull-down			50		KΩ
High-side flo	ating gate-	drive supply	•			·I	
	BOOT	Leakage current	VBOOT = 600V <sup>(2)</sup>			5	μA
	OUT	Leakage current	VOUT = 600V <sup>(2)</sup>			5	μA
		Synchronous bootstrap	V <sub>LSD</sub> = HIGH	1	250		Ω

Table 4. Electrical characteristics	(continued)
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1. Parameter in tracking

2. Specification over the -40°C to 125°C junction temperature range are ensured by design, characterization and statistical correlation

3. A pulse train has been sent to the HBCS pin with f=6KHz; the pulse duration is the one indicated in the notes as "TON"



# 5 Application information

## 5.1 Start-up sequence

## 5.1.1 Pre-heating (time interval A *Figure 5*)

After IC turn-on, unless a lamp absence is detected, the oscillator starts switching at a frequency ( $f_{PRE}$ ) set by values of C<sub>OSC</sub> and R<sub>RUN</sub> and R<sub>PRE</sub> *Figure 4*:

#### Equation 1

$$f_{\mathsf{PRE}} = \frac{1.328}{\mathsf{C}_{\mathsf{OSC}} \cdot (\mathsf{R}_{\mathsf{RUN}} \| \, \mathsf{R}_{\mathsf{PRE}})}$$

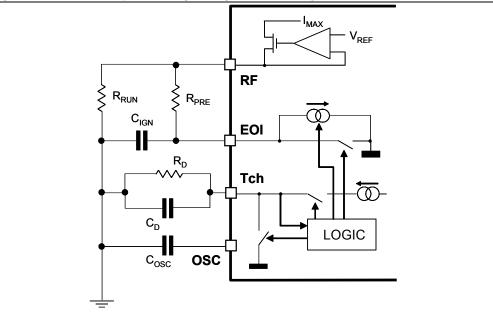
The *pre-heating time* is:

Equation 2

$$T_{PRE} = 4.63 \cdot \frac{C_D}{I_{CH}} + R_D \cdot C_D \cdot \ln \frac{4.63}{1.52}$$

where  $C_D$  and  $R_D$  are shown in Figure 4 and  $I_{CH}$  is typically 34  $\mu A.$ 

#### Figure 4. Oscillator, pre-heating and ignition circuitry



### 5.1.2 Ignition (time interval B Figure 5)

When the voltage at pin T<sub>CH</sub> drops down to 1.50V (typ.), the pin EOI is driven in high impedance state and C<sub>IGN</sub> is exponentially charged according to the time constant  $\tau$  given by C<sub>IGN</sub>\*R<sub>PBE</sub> that defines the *ignition time* and the frequency shift starts.

The *ignition time* is the time necessary to EOI voltage to reach 1.9V, so, by means of simple calculation:

### Equation 3

 $T_{IGN} = 3 \cdot C_{IGN} \cdot R_{PRE}$ 

During this phase, the half-bridge current control can **limit the maximum voltage applied to the lamp** by forcing small frequency increases whenever the half-bridge sense resistor voltage exceeds the HBCSH threshold (see the "Half-Bridge current control" paragraph).

*Figure 5*, centre and right, shows the L6585D behavior as the lamp gets older; if it doesn't ignite for a time longer than the pre-heating one (counted by a cycle charge/discharge of the  $T_{CH}$  pin), the IC is stopped, enters low consumption and waits for either a re-lamp or an UVLO.



## 5.1.3 Run mode (time interval C *Figure 5*)

As the voltage at EOI exceeds 1.9V and the lamp has ignited, the L6585D enters *Run mode* and remains in this condition unless one of the protections (all enabled in this mode) is trigged.

The switching frequency reaches the F<sub>RUN</sub> value set by R<sub>RUN</sub> and C<sub>OSC</sub>:

Equation 4

$$f_{RUN} = \frac{1.328}{R_{RUN} \cdot C_{OSC}}$$

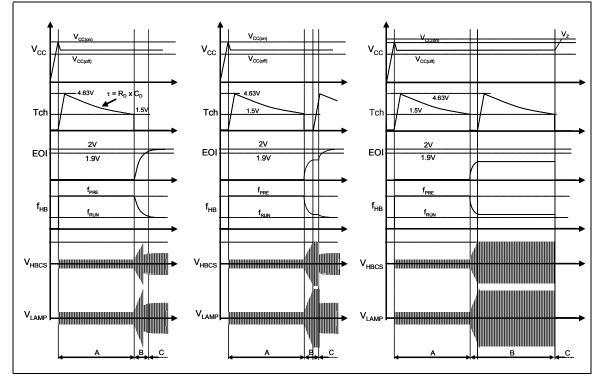


Figure 5. Oscillator, pre-heating and ignition sequence

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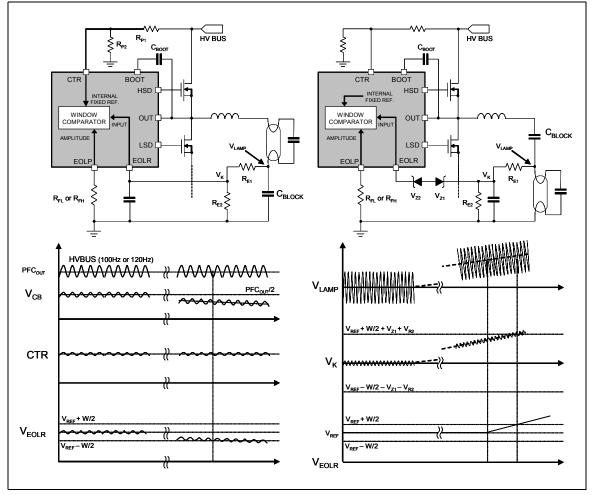
# 6 End of life – window comparator

To detect the ageing of the lamp with particular attention to the effect appearing as asymmetric rectification, a *programmable* window comparator has been introduced (centered around "V<sub>REF</sub>" with amplitude "V<sub>W</sub>") that triggers when the EOL-R voltage is higher than V<sub>REF</sub>+ V<sub>W</sub>/2 or lower than V<sub>REF</sub> – V<sub>W</sub>/2.

By means of the resistor connected to the EOLP pin, it is possible to select:

- 1. the *sensing mode*:
  - <u>fixed reference</u>: the centre of the window comparator (V<sub>REF</sub>) is fixed at 2.5V by an internal reference;
  - <u>tracking reference</u>: the centre of the window comparator is the voltage at pin CTR (that is a signal proportional to the PFC output voltage).
- 2. the half-window amplitude (V<sub>W</sub>/2): 220mV or 720mV.





The four possible configurations are summarized in the following table, together with the value of resistance to be connected to the EOLP pin in order to obtain the desired setting:

EOLP resistor	Symbol	Reference	Half-window amplitude
R <sub>EOLP</sub> > 620K	R <sub>FH</sub>	Fixed 2.5V	± 720mV
220K = R <sub>EOLP</sub> = 270K	R <sub>TL</sub>	Tracking with CTR	± 220mV
75K = R <sub>EOLP</sub> = 91K	R <sub>FL</sub>	Fixed 2.5V	± 220mV
22K = R <sub>EOLP</sub> = 27K	R <sub>TL</sub>	Tracking with CTR	± 720mV

Table 5. Configuration of the EOLP pin

<u>Tracking reference</u>: this setting is suitable for the block capacitor to ground configuration (*Figure 6*, left).

In this case the window comparator centre is set by the CTR voltage that is internally transferred to the EOL structure.

The effect of rectification appears as shifting of the DC voltage component across the block capacitor, which, under normal conditions, equals one half of the PFC output voltage.

A signal proportional to the DC block capacitor voltage is sent to the EOL-R pin by means of a resistive divider ( $R_{E1}$  and  $R_{E2}$ ); the dividers  $R_{E1}$  and  $R_{E2}$  and  $R_{P1}$  and  $R_{P2}$  must be designed to set the EOL-R voltage equal to CTR under nominal condition.

Fixed reference: this setting is suitable for the lamp to ground configuration (Figure 6, right).

The effect of rectification appears as shifting of the DC lamp voltage.

A resistive divider ( $R_{E1}$  and  $R_{E2}$ ) senses the voltage across the lamp under normal condition, that is an AC signal with zero average value whereas in case of asymmetric rectification the DC value can shift either in positive or negative direction. Two Zener diodes can be connected back-to-back between the EOL-R pin and the centre of the resistive divider.

The Zener voltages should differ by an amount as close as possible to the double of the internal reference to have a symmetrical detection, as it can easily obtained from the following equations:

- $V_{UP} = V_{REF} + W/2 + V_{Z1} + V_{R2}$
- $V_{DOWN} = V_{REF} W/2 V_{Z2} V_{R1}$

where  $V_{UP}$  and  $V_{DOWN}$  are the  $V_{K}$  values (equal in absolute value) that trigger the window comparator.

To avoid an immediate intervention of the EOL protection, a filtering is introduced; as long as the fault condition persists, the Tch internal generator charges the  $C_D$  up to 4.63V and then it opens. If this fault condition is still present when the Tch voltage decreases down to 1.5V, then the half bridge is stopped, otherwise (if the fault disappears) the counting is stopped and reset.

## 7 Half-bridge current control

The information about the lamp current can be obtained by reading the voltage across a sense resistor placed in series to the source of the half-bridge low side MOS.

This circuitry is enabled at the end of the pre-heating phase and it enriches the L6585D with two features:

- Controlled lamp voltage/current during <u>ignition</u> (Figure 5): by properly setting the sense resistor (such that the V<sub>HBCS</sub> level is crossed in correspondence of a lamp voltage higher than the ignition voltage) it is possible to limit the maximum lamp voltage during ignition. In case of this occurrence, then the L6585D would react with a small frequency increase that allows limiting the lamp voltage (V<sub>+IGN</sub>). This also prevents the risk of crossing the resonance frequency of the L<sub>BALLAST</sub>C<sub>RES</sub> circuit. If the lamp ignites before T<sub>CH</sub> reaches 1.50V (*Figure 5* left) that is EOI has exceeded 1.9V, then:
  - EOI internal switch opens and its voltage moves asymptotically to 2V
  - The switching frequency reaches the operating one;
  - When T<sub>CH</sub> reaches 1.52, it will be discharged

If instead that the lamp hasn't ignited after a time equal to the pre-heat time (*Figure 5* right) the oscillator stops, the chip enters low consumption mode and this condition is latched until the mains supply voltage is removed or a re-lamp is detected.

 Over-current protection during <u>run mode</u>: if the HBCSL threshold is crossed, the T<sub>CH</sub> internal generator is turned on as well as the one at pin EOI causing a frequency increase: this implements a current control structure.

During *run mode* another protection is active: a second comparator (HBCSH) on the pin HBCS detects anomalous current flow through the sense resistor such as the spikes generated by the **capacitive mode**; the crossing of this second threshold latches the IC.



# 8 CTR

This is a multi-function pin, connected to a resistive divider to the PFC output bus:

- <u>PFC over-voltage:</u> in case of PFC output overshoot (e.g. at start-up) that causes a threshold crossing, the PFC section stops switching until the pin voltage falls below 3.26V (typ.); this is helpful because the bandwidth of the PFC error amplifier is narrow so the control loop is not fast enough to properly reacts
- Feedback disconnection: The OVP function above described (together with the static one embedded in the PFC error amplifier) is able to handle "normal" over-voltage conditions, i.e. those resulting from an abrupt load/line change or occurring at start-up. In case of over-voltage generated when the upper resistor of the feedback output divider fails open, the control loop can no longer read the information on the output voltage and will force the PFC pre-regulator to work at maximum ON time; if this occurs (i.e. the pin INV falls below 1.2V, typ.) and the CTR detects an OVP, the gate drivers activity is immediately stopped, the device enters low consumption and the condition is latched as long as the IC supply voltage is above the UVLO threshold;
- <u>Reference</u> for EOL in case of tracking reading.
- <u>Disable</u>: by forcing the pin below 0.75V an immediate unlatched shut-down is activated; it can be also used as **re-lamp** in fact after the pin voltage is above 0.8V a preheating/ignition sequence is repeated.



# 9 Re–lamp

A second comparator has been introduced on the pin EOL-R; a voltage higher than the internal threshold is read as **lamp absence** so the chip suddenly stops switching, enters idle mode (low consumption) and is ready for a new pre-heating/ignition sequence as soon as a new lamp is inserted.

In this idle mode the consumption of the chip is reduced so that the current flowing through the resistors (connected to the high voltage bus for the start-up) is enough to keep the  $V_{CC}$  voltage above the UVLO threshold.

After a re-lamp cycle (that is the EOL-R voltage is brought above 4.63V and then released below), a new pre-heating/ignition sequence starts.

#### Table 6. IC configuration

	Pre-heating	Ignition	Run mode
Time duration	$T_{CH}\ cycle^{(1)};$ It depends on $R_D$ and $C_D$	EOI charge from 0 to 1.9V (typ.); It depends on R <sub>D</sub> and C <sub>D</sub>	Until a fault appears or the AC Mains is removed
Half-bridge switching frequency	$f_{PRE} = \frac{1.328}{C_{OSC} \cdot (R_{RUN} \   R_{PRE})}$	The frequency shifts from f <sub>PRE</sub> to f <sub>RUN</sub> with exponential trend	$f_{RUN} = \frac{1.328}{R_{RUN} \cdot C_{OSC}}$
RELAMP comparator	ENABLED	ENABLED	ENABLED
CTR: PFC overvoltage	ENABLED	ENABLED	ENABLED
CTR: disable function	ENABLED	ENABLED	ENABLED
Half-bridge current sense	DISABLED	$\begin{array}{c} ENABLED \\ - \ low \ threshold \Longrightarrow \\ disabled \\ - \ high \ threshold \Longrightarrow \\ F_{SW} \ increase \end{array}$	$\begin{array}{c} ENABLED \\ - \text{ low threshold} \Rightarrow \\ F_{SW} \text{ increase} \\ - \text{ high threshold} \Rightarrow \\ latch \end{array}$
EOL: window comparator	DISABLED	DISABLED	ENABLED
PFC choke saturation	ENABLED	ENABLED	ENABLED

1. T<sub>CH</sub> cycle: charge of the T<sub>CH</sub> voltage up to 4.63V and discharge down to 1.50V following the R<sub>D</sub>C<sub>D</sub> time constant



Fault	Condition	IC behavior	Action required	
Lamp absence (re-lamp comparator)	<i>At turn-on</i> : EOL-R voltage higher than 4.63V	<ul> <li>The T<sub>CH</sub> charge doesn't start (no ignition)</li> <li>Drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Lamp replacement (EOL-R below 4.63V)	
	<i>Run mode</i> : EOL-R voltage higher than 4.63V	<ul> <li>All drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>		
End of life	EOL-R voltage outside the limits of window comparator	<ul> <li>T<sub>CH</sub> cycle <sup>(1)</sup> (reset if the fault disappears)</li> <li>drivers stopped at the end of T<sub>CH</sub> cycle</li> <li>IC low consumption (V<sub>CC</sub> clamped)</li> </ul>	Re-lamp cycle <sup>(2)</sup>	
Half-bridge current sense	<i>Ignition</i> : HBCS threshold	<ul> <li>T<sub>CH</sub> cycle <sup>(1)</sup> with lamp voltage control</li> <li>In case of HBCS at the end of the TCH cycle, drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Re-lamp cycle <sup>(2)</sup>	
	Run mode: HBCSL threshold	<ul> <li>T<sub>CH</sub> cycle <sup>(1)</sup> with lamp voltage control (frequency increase)</li> <li>In case of HBCS at the end of the TCH cycle, drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Re-lamp cycle <sup>(2)</sup>	
	<i>Run mode</i> : HBCSH threshold	<ul> <li>Drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Re-lamp cycle <sup>(2)</sup>	
Shut-down	CTR voltage lower than 0.8V	<ul> <li>Drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	When the CTR voltage returns above 0.8V, the IC driver restart with a pre-heating sequence	
Choke saturation	PFCS voltage higher than 1.6V	<ul> <li>Drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Re-lamp cycle (2)(3)	
Over-voltage of PFC output	CTR voltage higher than 3.4V	<ul> <li>PFC driver stopped</li> </ul>	When the CTR voltage returns below 3.26V (Typ.), the PFC driver restarts	
PFC open loop (feedback disconnection)	CTR voltage higher than 3.4V AND INV voltage lower than 1.2	<ul> <li>Drivers stopped</li> <li>IC low consumption (V<sub>cc</sub> clamped)</li> </ul>	Re-lamp cycle <sup>(2)(3)</sup>	

#### Table 7. Fault conditions

1.  $T_{CH}$  cycle: charge of the  $T_{CH}$  voltage up to 4.63V and discharge down to 1.50V following the  $R_DC_D$  time constant;

2. Re-lamp cycle: the voltage at EOL-R pin must be first pulled above 4.63V and then released below it; this typically happens in case of lamp replacement. After a re-lamp cycle, a new pre-heating sequence will be repeated.

3. This fault actually is a "board" fault so a lamp replacement is not effective to restart the ballast



# 10 Package mechanical data

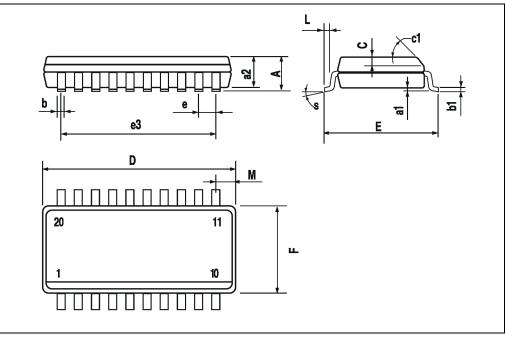
In order to meet environmental requirements, ST offers these devices in ECOPACK<sup>®</sup> packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.



	Dimensions					
Ref.	mm.			inch		
	Min.	Тур.	Max.	Min.	Тур.	Max.
А			2.65			0.104
a1	0.1		0.2	0.004		0.008
a2			2.45			0.096
b	0.35		0.49	0.014		0.019
b1	0.23		0.32	0.009		0.012
С		0.5			0.020	
c1	45° (typ.)					
D	12.60		13.00	0.496		0.512
E	10.00		10.65	0.393		0.419
е		1.27			0.050	
e3		11.43			0.450	
F	7.40		7.60	0.291		0.300
L	0.50		1.27	0.020		0.050
М			0.75			0.029
S	8° (max.)					

Table 8. SO-20 mechanical data

## Figure 7. Package dimensions





# 11 Order codes

Table 9. Order codes

Part Number	Package	Packaging
L6585D	SO-20	Tube
L6585DTR	SO-20	Tape and Reel



# 12 Revision history

## Table 10. Revision history

Date	Revision	Changes
12-Jan-2006	1	Initial release
25-Oct-2006	2	Final datasheet
21-Dec-2006	3	Updated f <sub>RUN</sub> value on <i>Table 4: Electrical characteristics on page 8</i>
12-Apr-2007	4	Updated electrical values on Table 4
23-May-2007	5	Updated Figure 1: Block diagram on page 1 and Eq.1 and 4



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